

<b>Notice of References Cited</b>	Application/Control No. 10/026,427	Applicant(s)/Patent Under Reexamination CHOI ET AL.	
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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	B	US-2002/0048266 A1	04-2002	Choi et al.	370/331
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**NON-PATENT DOCUMENTS**

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